

Notice of References Cited		Application/Control No. 10/722,678 , 901007164	Applicant(s)/Patent Under Reexamination ISHIDA ET AL.	
		Examiner Lien T. Tran	Art Unit 1761	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,432,464	08-2002	Andersen et al.	426/548
*	C	US-5,510,508	04-1996	Claude et al.	560/41
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	M	US-			

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NON-PATENT DOCUMENTS

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